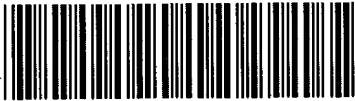


<b>Issue Classification</b> 	<b>Application No.</b>	<b>Applicant(s)</b>	
	09/256,386	MULLER ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Dah-Wei D. Yuan	1745	

ISSUE CLASSIFICATION											
ORIGINAL					CROSS REFERENCE(S)						
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
429		15			429	12	13	19			
INTERNATIONAL CLASSIFICATION											
H	0	1	M	8/04							
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				/							
				/							
Dah-Wei Yuan 2/6/04 (Assistant Examiner) (Date)					Patrick Ryan Supervisory Patent Examiner Technology Center 1700 (Patent Examiner) (Date)					Total Claims Allowed: 34	
<i>[Signature]</i> (Legal Instruments Examiner) (Date)					<i>[Signature]</i> (Patent Examiner) (Date)					O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant						<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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